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Bib Data Sheet

CONFIRMATION NO. 2278

SERIAL NUMBER 09/975,835	FILING DATE 10/11/2001 RULE	ر ر	324 714	GROL	GROUP ART UNIT		ATTORNEY DOCKET NO. 6920/0J924	
APPLICANTS Hiroshi Koshiba, Tokyo, JAPAN; ** CONTINUING DATA **********************************								
Foreign Priority claimed 35 USC 119 (a-d) conditions The priority claimed 35 USC 119 (a-d) conditions The priority claimed Allowante Verified and Acknowledged Examiner's Signature Infitials			STATE OR COUNTRY JAPAN			TOT CLAI 8	MS	INDEPENDENT CLAIMS 2
ADDRESS 07278								
TITLE Semiconductor test apparatus and control method therefor								
RECEIVED No.	FILING FEE FEES: Authority has been given in Paper RECEIVED No to charge/credit DEPOSIT ACCOUNT				☐ All Fees ☐ 1.16 Fees (Filing) ☐ 1.17 Fees (Processing Ext. of time) ☐ 1.18 Fees (Issue) ☐ Other ☐ Credit			